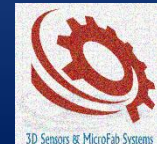
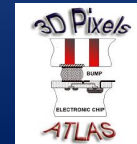


3D sensors and Micro Fabricated Systems

Cinzia Da Vià, The University of Manchester, UK



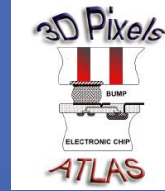
Outline

- ❖ 3D sensors
- ❖ Micro-Fabrication
- ❖ Applications in Bio-Medicine and Space, Else
- ❖ Wow can HEP profit from "More than Moore" ?

3D for the ATLAS IBL by the 3DATLAS R&D Collaboration

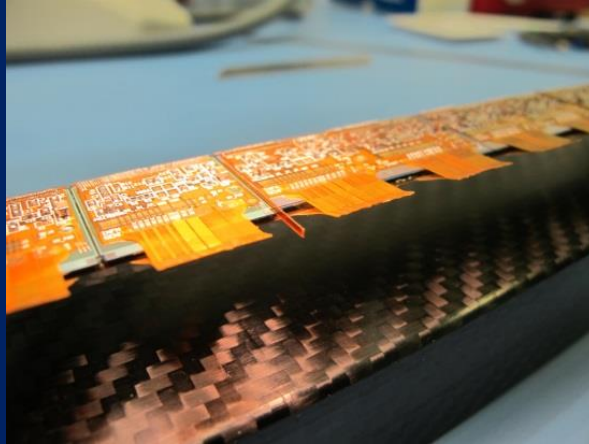
25% of the total IBL modules

NIMA 694 (2012) 321-330



total pixel number:
26880

Total number of columns per chip :
>100.000

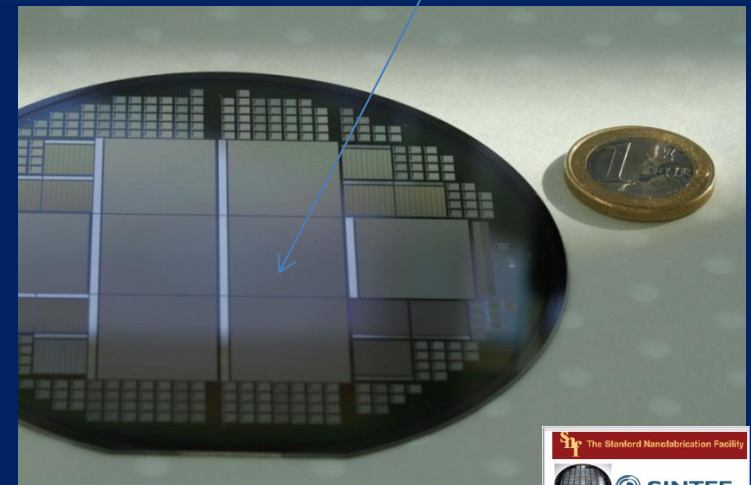
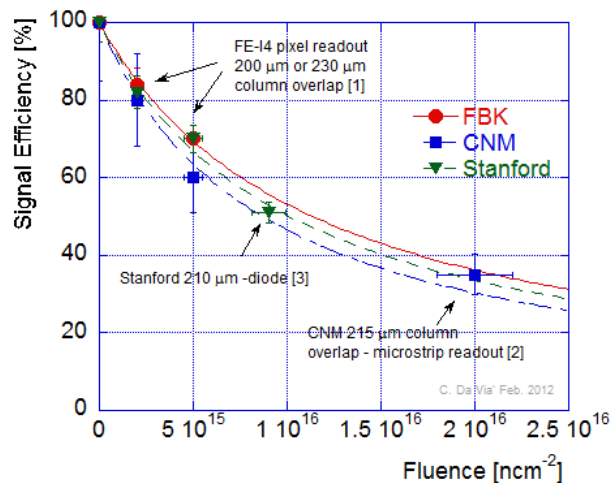


4+1 runs were completed in February and October 2012 by CNM (Barcelona, Spain) and FBK (Trento, Italy) with double side process with >350 good chips, more than 100 wafers and an yield exceeding 60% fulfilling the following:

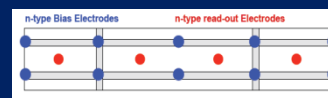
Sensor specifications for IBL:

- Quality to $5 \times 10^{15} n_{eq}$
- max. power dissipation: 200 mW/cm² at -15 C
- tracking efficiency > 98%.

V_{bias} is less than 300V at all fluences



IES=71μm

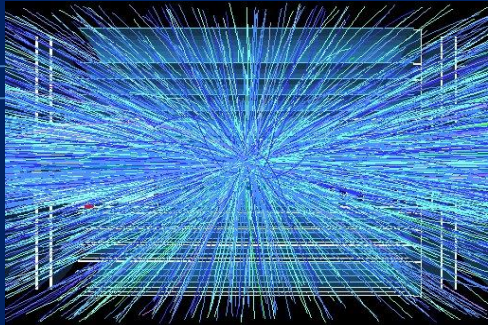


50μm

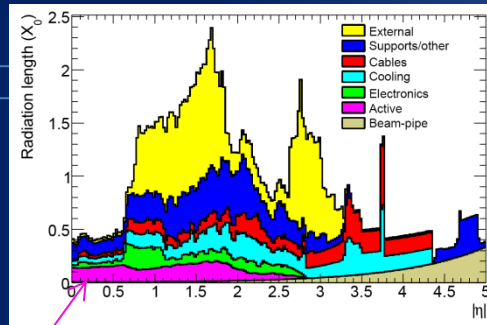
250μm



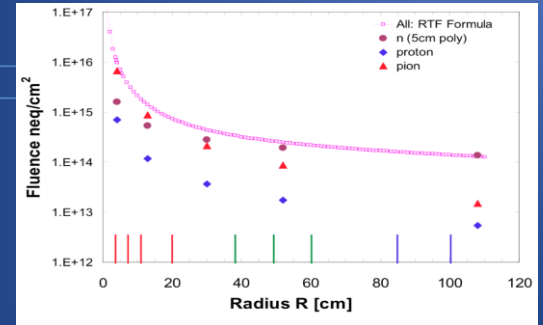
The HL-LHC ATLAS Vertex detectors challenges:



Precision reconstruction
Needs the signal over threshold

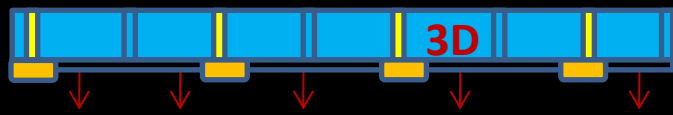


Material budget
is not the sensor IBL 1.5% X_0



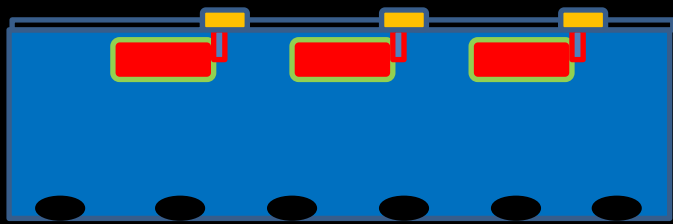
Radiation tolerance
and power budget

Micro-Fabrication offers possible solution:



50-100 μm
3D thickness

❖ Thin (or thick) 3D silicon sensor modules with active edges



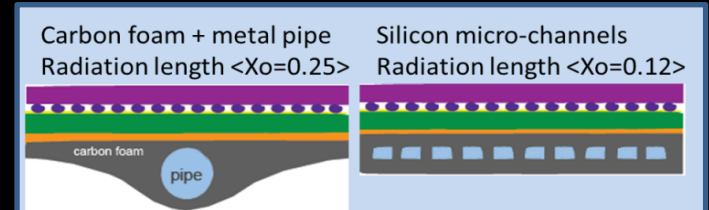
150-200 μm
After backfinning

❖ Interconnected with micro-bump bonds and through chip bias supply



~50 μm
cap

❖ Embedded micro-cooling



3D layout: Thin Versus Thick at $2 \times 10^{16} \text{ ncm}^{-2}$

Thin (50-100 μm):

Aggressive

- Needs support wafer (and to remove it)
- Lower capacitance
- Smaller electrodes (full sensitivity)
- Smaller generated signal (requires charge multiplication to reliably work)

Thick (150-200 μm)

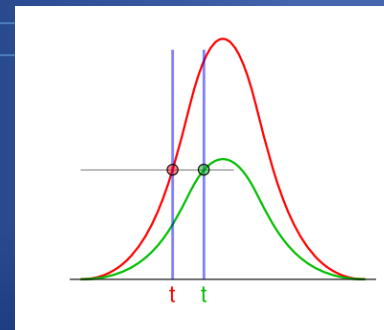
Conservative

- Double side processing
- Alternative active edges (to qualify)
- Higher capacitance for aggressive IES
- Bigger electrodes (possible dead regions)
- Bigger generated signals (in case charge multiplication not reliable)

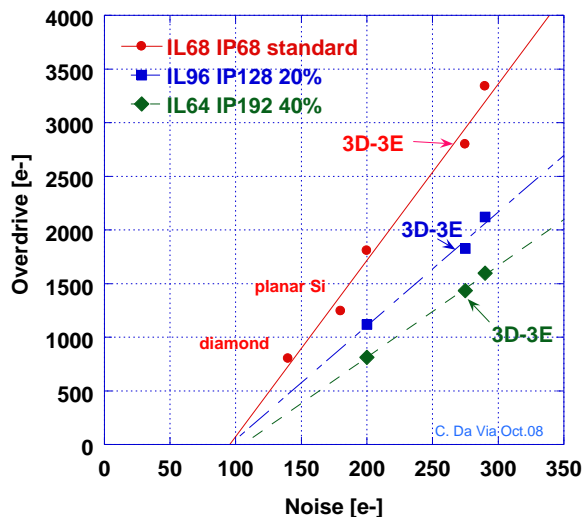
But what is the minimum signal after irradiation to be over threshold?
(required min signal = (threshold + overdrive) \times 2) Assume to use 4E 3D
Layout with 56 μm IES note IBL used 3E = 71 μm

Required signal. Threshold and overdrive measurements using FE-I3

- No data available with FE-I4 and 3D yet
- Overdrive is different at different FE power consumptions (more power less overdrive)
- Time walk and overdrive depend on C
- In time threshold = bare threshold + overdrive
- Required signal = in time threshold $\times 2$



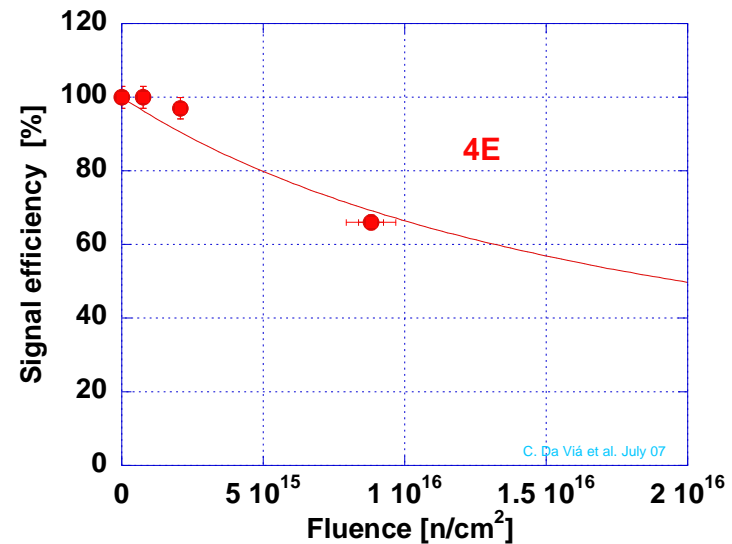
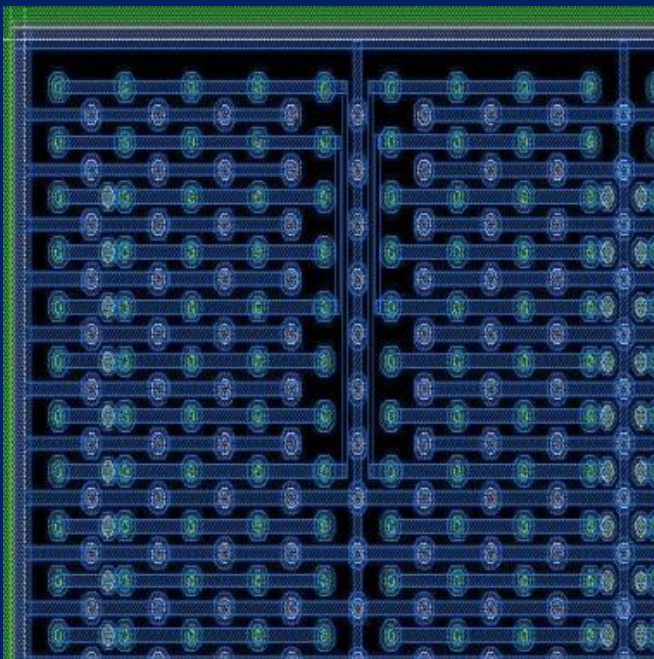
Threshold triggered system
 Difference between \uparrow and \uparrow gives the time walk
 New bunch crossing every 25ns
 Need to cross threshold within 20ns to be accepted
 How much overdrive is needed to cross threshold within 20ns?



Sensor	Bare Threshold [e-]	OverdriveI P68 IL68 [e-] Nominal P	Overdrive IP128 IL96 [e-] +20% P	Overdrive IP192 IL64 [e-] +40%P
Si planar	2500	1250		
3D-2E	2500	1800	1120	820
3D-3E	3200	2800	1830	1440
3D-4E	3200	3340	2130	1600
Diamond	1500	800		

3D 4E after 2×10^{16}

- ❖ 56 μm inter electrode spacing
- ❖ At 2×10^{16} expected signal is 50% from original one at 100V!
- ❖ $200 \mu\text{m} \times 75 = 15\,000/2 = 7500e$

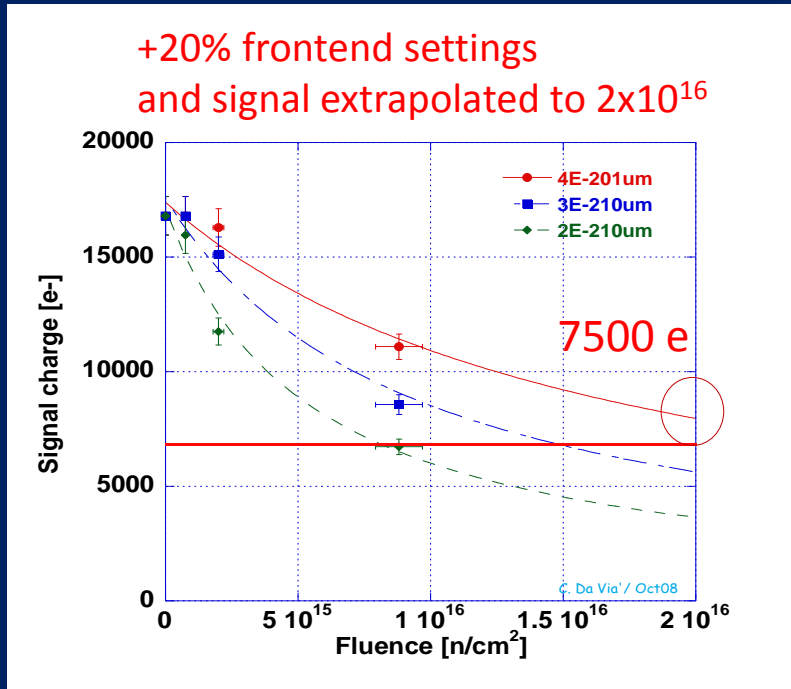


Required Signal after 2×10^{16}

- ❖ Use FE-I4 bare threshold (1300e)
- ❖ Use measured overdrive for 4E with FE-I3 + 20% (2130 e) to compensate for 65nm speed (extra power taken into account in total budget)

Required signal = [Bare Threshold + Overdrive] $\times 2 = 6860 e^-$

✓ Available signal = $\sim 7920 e^-$ (50um) or $\sim 7500e^-$ (200um)



FE-I3

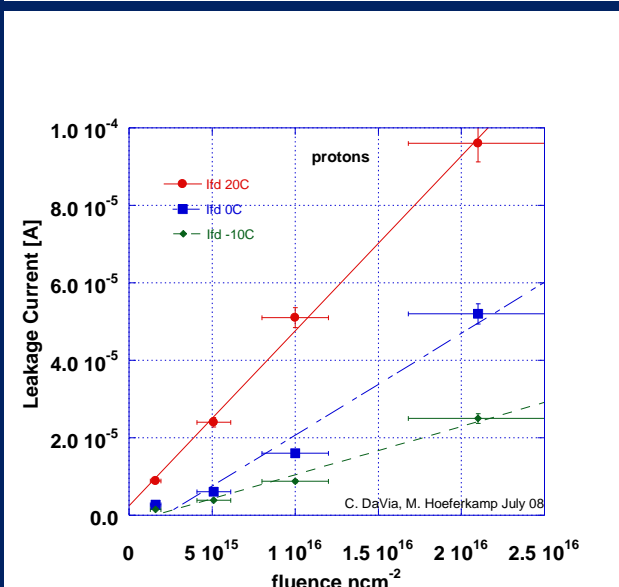
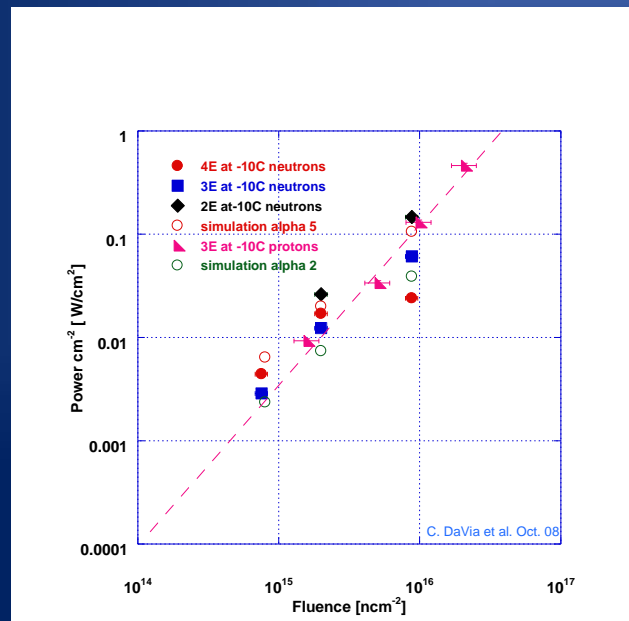
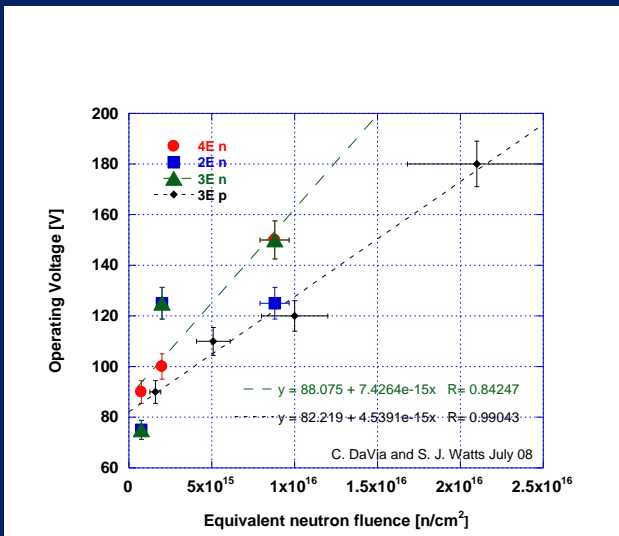
Sensor	Bare Threshold [e-]	Overdrive IP128 IL96 [e-]	In time Threshold [e-]	Required signal [e-]
Si planar	2500			
3D-2E	2500	1120	3620	7240
3D-3E	3200	1830	5030	10060
3D-4E	3200	2130	5330	10660
diamond	1500			

FE-I4 (extrapolation at same FE-I3 overdrive)

Sensor	Bare Threshold [e-]	Overdrive [e-]	In time threshold [e-]	Required signal [e-]
3D-4E	1300	2130	3430	6860

Bare 3D Power dissipation Up to $2 \times 10^{16} \text{ ncm}^{-2}$

Processing: J. Hasi Manchesteri, C. Kenney, MBC
Measurements: M. Hoferkamp UNMT, Slavicek Prague
Analysis and simulation C. DaVia, S. Watts, Manchester



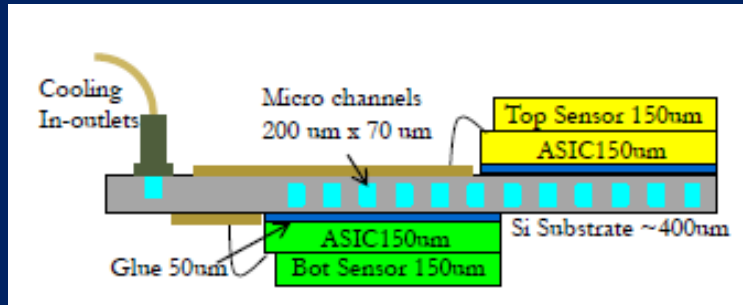
Power/ cm^2 at -10°C

At $1.0 \times 10^{15} \text{ ncm}^{-2} \sim 3 \text{ mWcm}^{-2}$
 At $5.0 \times 10^{15} \text{ ncm}^{-2} \sim 33 \text{ mWcm}^{-2}$
 At $1.0 \times 10^{16} \text{ ncm}^{-2} \sim 120 \text{ mWcm}^{-2}$

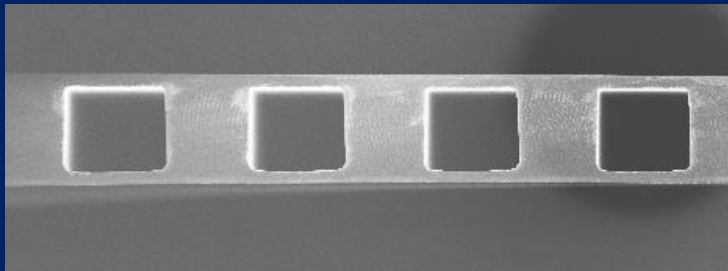
At $2.1 \times 10^{16} \text{ ncm}^{-2} \sim 443 \text{ mWcm}^{-2}$

Micro-channel cooling

Pioneering work for HEP
within CERN PH-DT



LHCb system layout. J. Buytaert,
Pixel2012



- ❖ Explored since a while in microprocessor industry

Cooling channel is integrated in the substrate:

- ❖ Can customize the routing of channels to run exactly under the heat sources.

Many parallel channels:

- ❖ large liquid-to-substrate heat exchange surface.

Low mass :

- ❖ No extra 'bulky' thermal interface required between cooling channel and substrate.

No heat flows in the substrate plane:

- ❖ Small thermal gradients across the module.

All material is silicon :

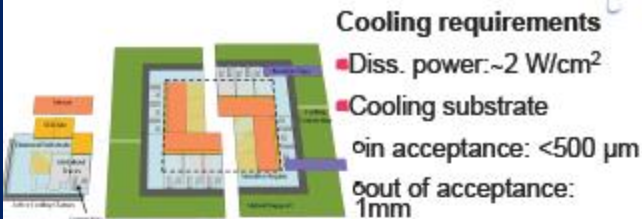
- ❖ No mechanical stress due to CTE mismatch.

⦿ csem

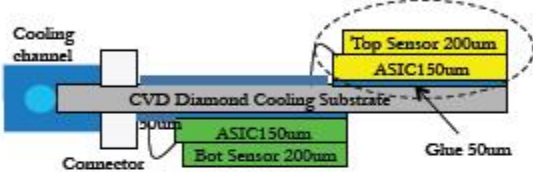
Copyright 2013 CSEM | Div C | A.Pezous | Page 9

- Cooling device based on the ATLAS design
- Pressure tests >100bar

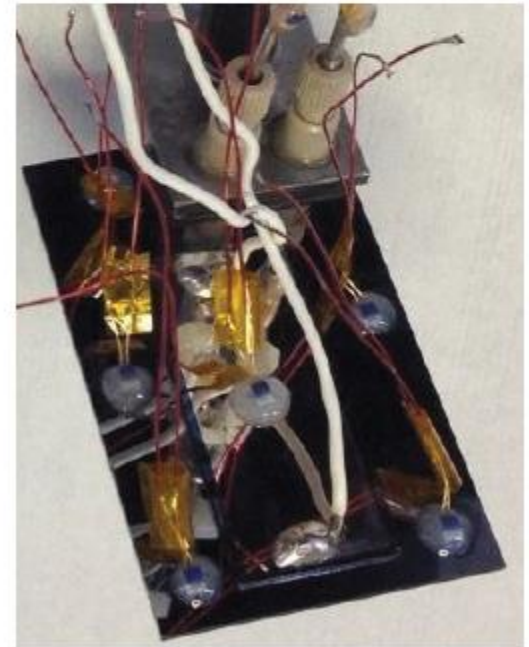
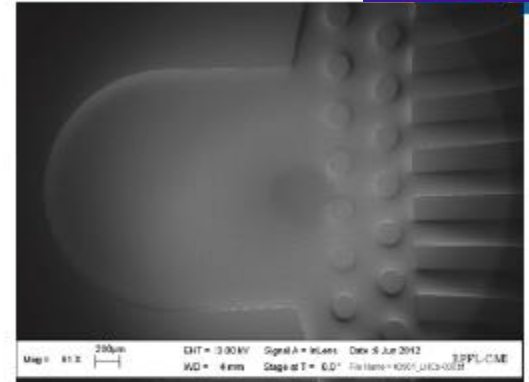
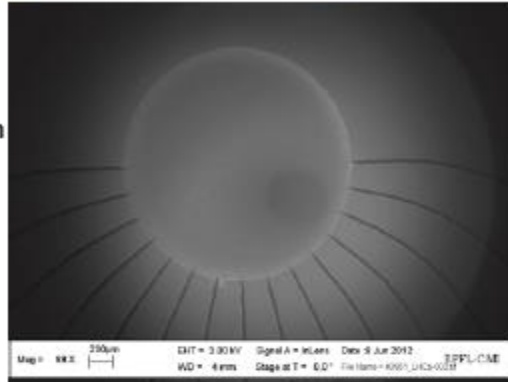
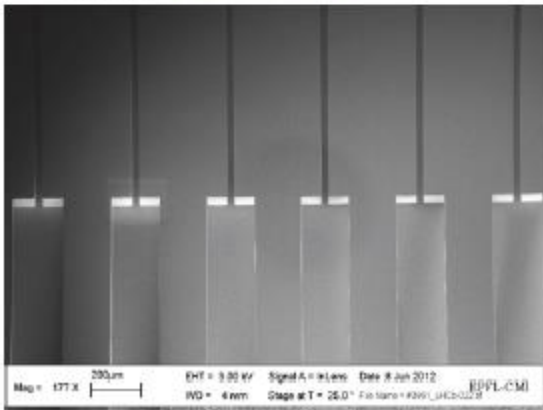
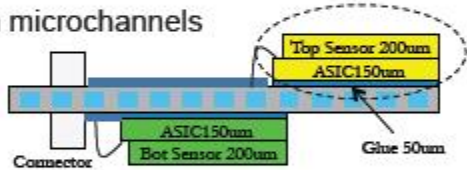
LHCb VELO Upgrade using CO2 Cooling



passive Diamond substrate



Silicon microchannels



Cooling Power Test

Test sample equipped
With cooling tubes, heater
And Pt100 probes

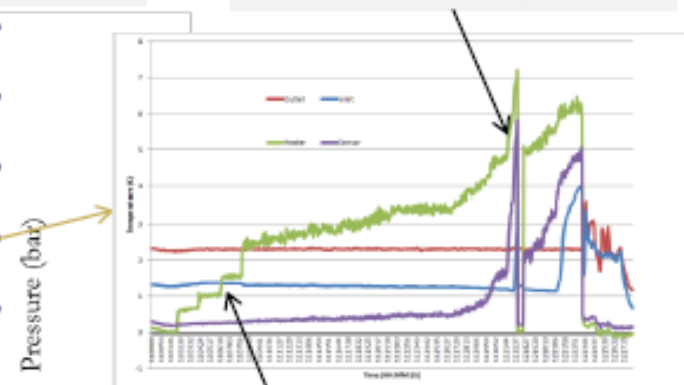
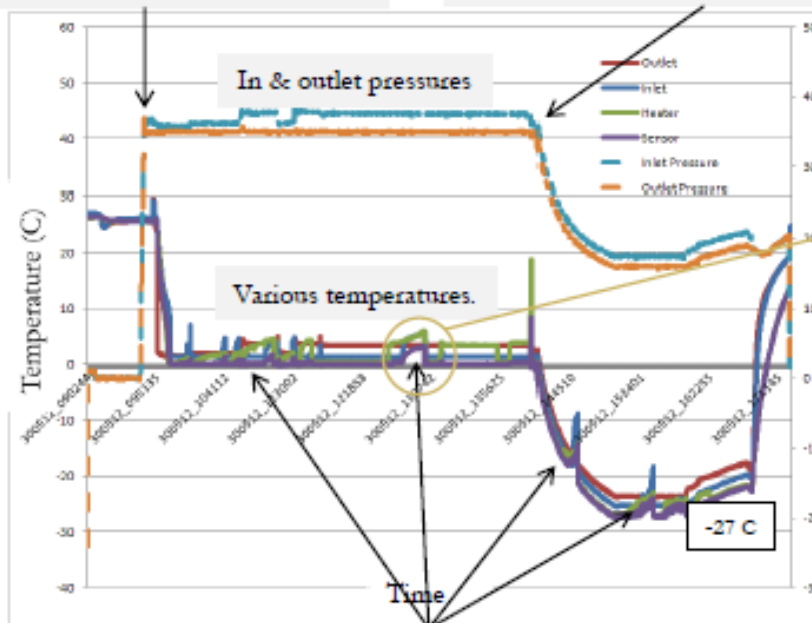


Still with old NanoPorts
(Upchurch Scientific, UK)
Guaranteed up to 103bars
But bonded to surface with adhesive
Polymer rings not guaranteed for radiation
hardness and thermal cycling

1. CO2 enters micro channels.
Sample cools down to 0 C

3. CO2 pressure is lowered.
Temperature decreases to -26 C.

CO2 can no longer
evacuate heat : "dry-out"



Heating power is increased stepwise

Cooling power achieved:

1.9W/cm² at T= 0 C,
0.5W/cm² at T=-27 C

Limited by achievable mass flow (pump limit)
Expect much higher with improved pump !

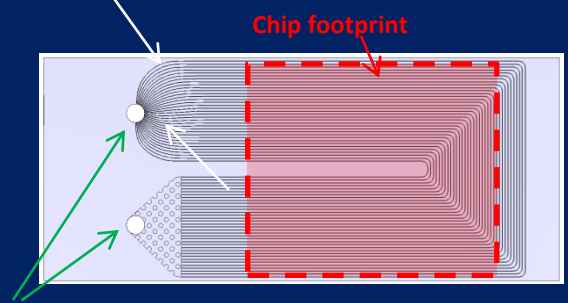
2. Heater is switched on/off.

New 3D + ATLAS Prototype

1st design:

35 micro-channels
 50 x 50 μm separated by 200 μm wide walls

Restrictions
 (10 μm wide x 50 μm deep, 7 mm long)
 to bring CO₂ in critical conditions at the channels entrance

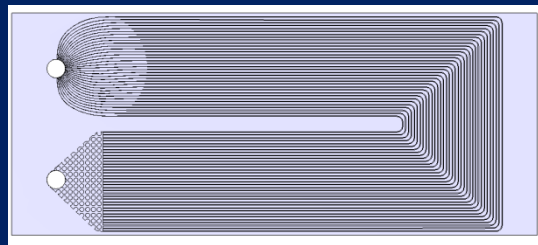


2 holes for fluidic inlet and outlet
 (1.6 mm diameter)

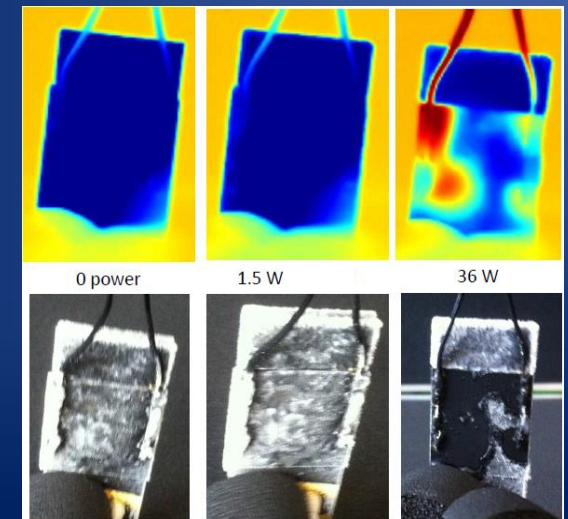
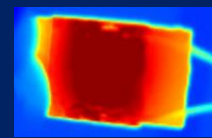
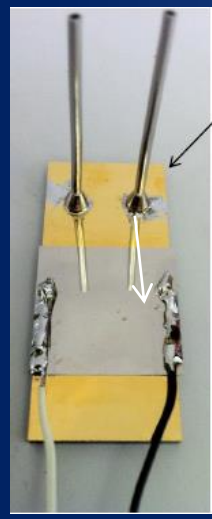
Pillars in the outlet
 to maximize the bonded surface

2nd design:

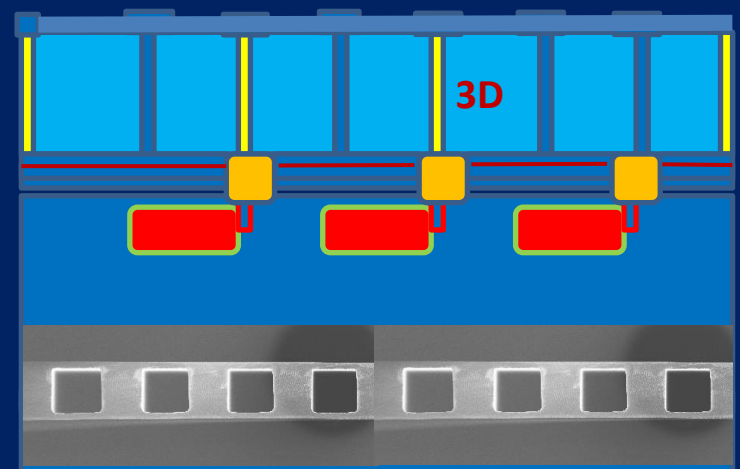
Increased the depth of channels and restrictions to 190 μm!
 - Increased the pitch between the pillars to increase the device strength (and so the maximum sustainable pressure)



Manufactured at CSEM
 Measurements Giulia Romagnoli



No cooling!!!



300 μm 100 μm 230 μm

Cooling where it needs at 2×10^{16} n/cm²

❖ P3D+=Power density 3D sensors: Use existing data = **442mW/cm² with ~200V bias voltage and 200um thickness**

❖ FE- 65nm TARGET FOR FE-65 IS 400mW/cm²

❖ PTOT= Power density module = [(P3D+PROC)]

= 442 + 400 =

850mW/cm²

For **planar sensors** the radiation induced Leakage current is the same but the bias voltage is ~ 5 times larger so a rough estimate for the power dissipation for the module is

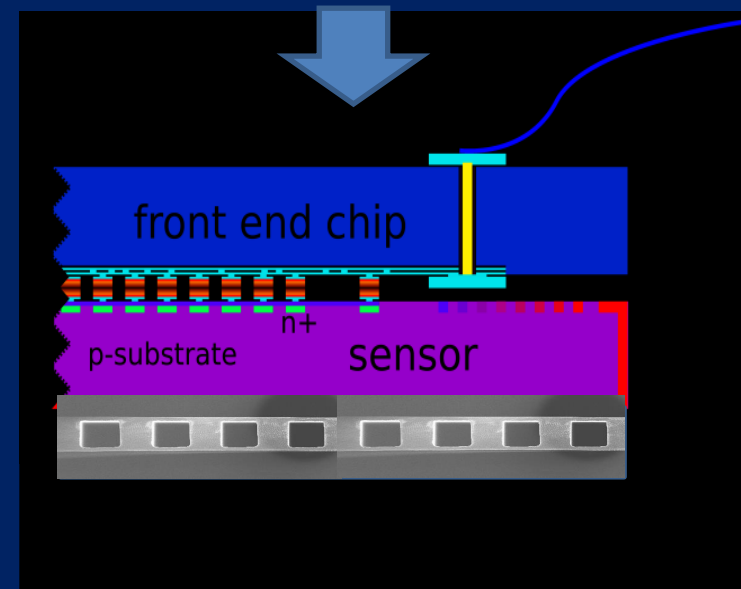
~ 2.5 W/cm²

This figure is similar to the VELO detector

Ongoing Development FBK, CSEM, CERN PhDT with the program of



Cooling channel could be embedded on the sensor side to be effective!

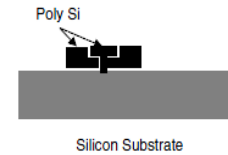
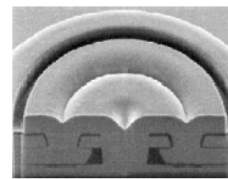


Micro-Fabrication?

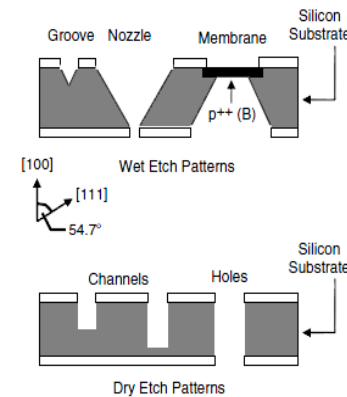
In Micro-fabrication, used mainly for Micro-Electro Mechanical Systems (MEMS), the process is performed 3 dimensionally within the silicon volume

- ❖ Surface: Structures are formed by deposition and etching of sacrificial and structural thin films
- ❖ Bulk, Volume: 3D structures formed by dry or wet etching of silicon substrates
- ❖ LIGA: 3D structures formed by mold fabrication followed by injection molding or electroplating

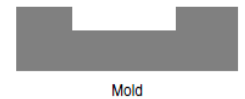
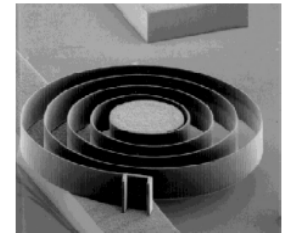
surface



bulk



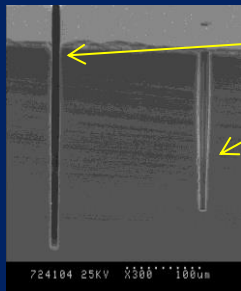
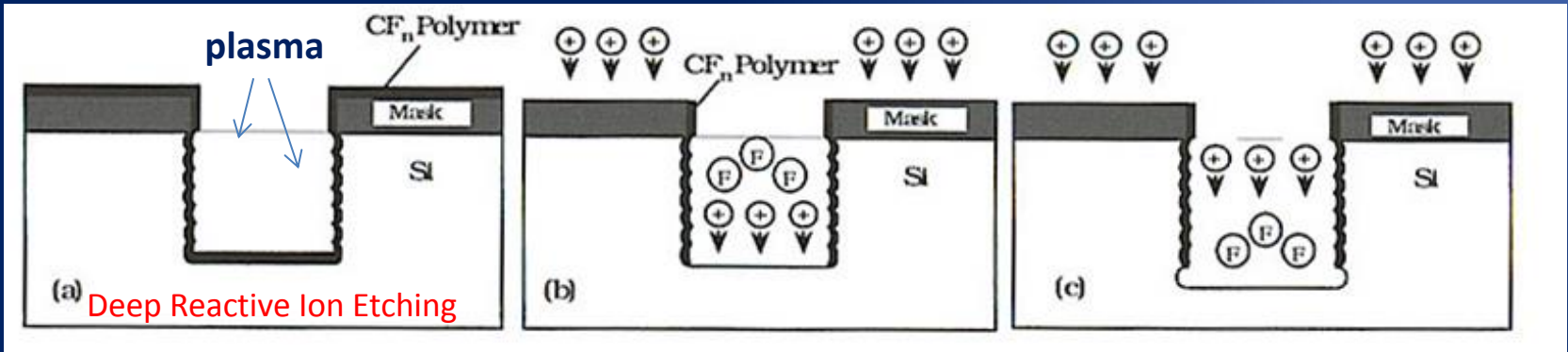
Liga



Applications:

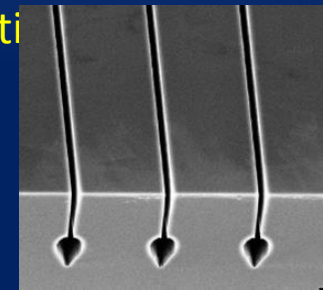
- Everyday life (cars, portable devices..)
- Medical/Biology
- Space
- HEP
- ... others..

"Bulk": Deep Reactive Ion Etching



For 3D sensors electrode definition and active edges

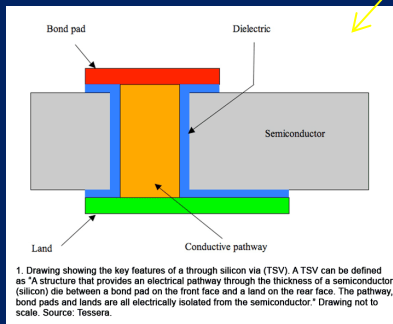
For cooling micro-channels



Bosh Process

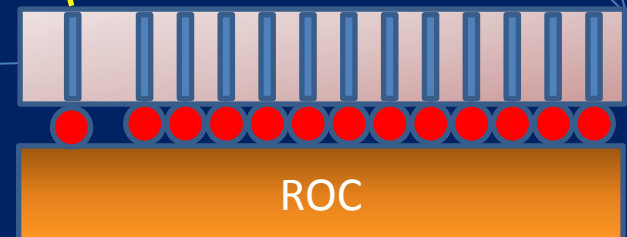
Interconnectivity

Using Tsv



Extra holes
On 3D sensor side
To carry signal out

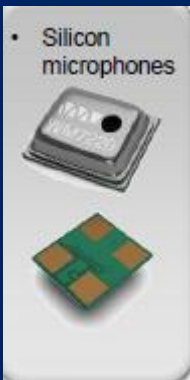
1- conformal metal
2-doped poly



Industry: MEMS Sensors and actuators

Sensing Applications

Voice/ sound



Motion/ position



Pressure/ monitoring



TPMS
Tire pressure monitoring system

Actuating Applications

Projecting Receiving light



Surface acoustic wave

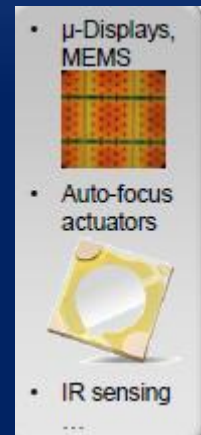
RF Related functions



Managing fluids

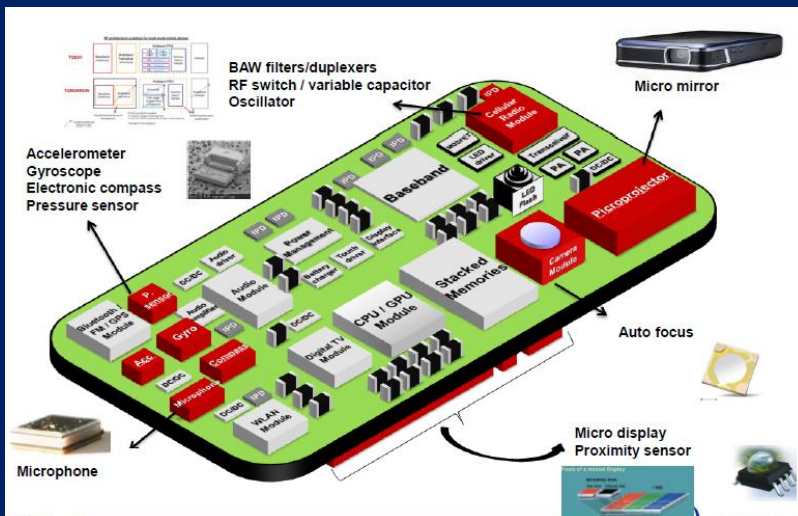
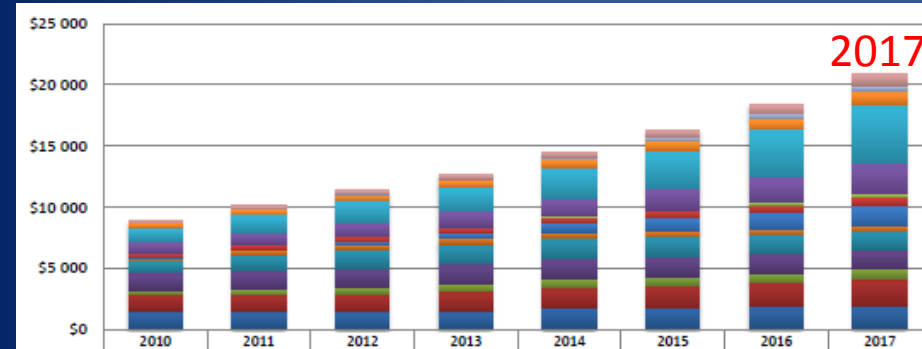
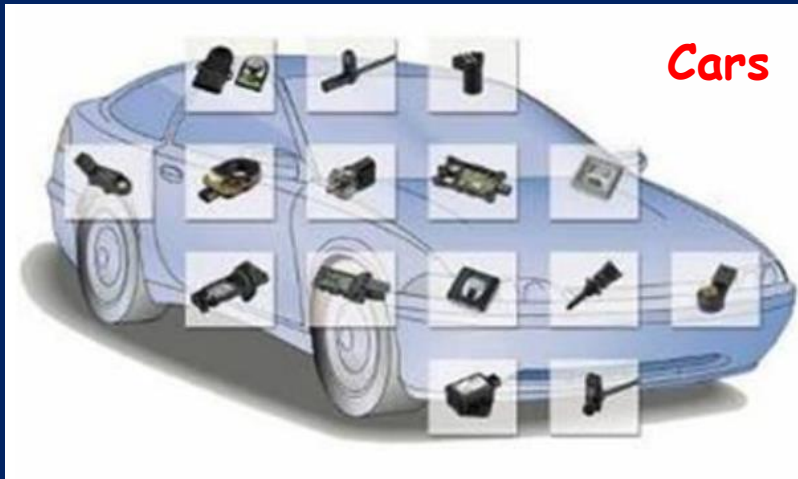


Emerging MEMS



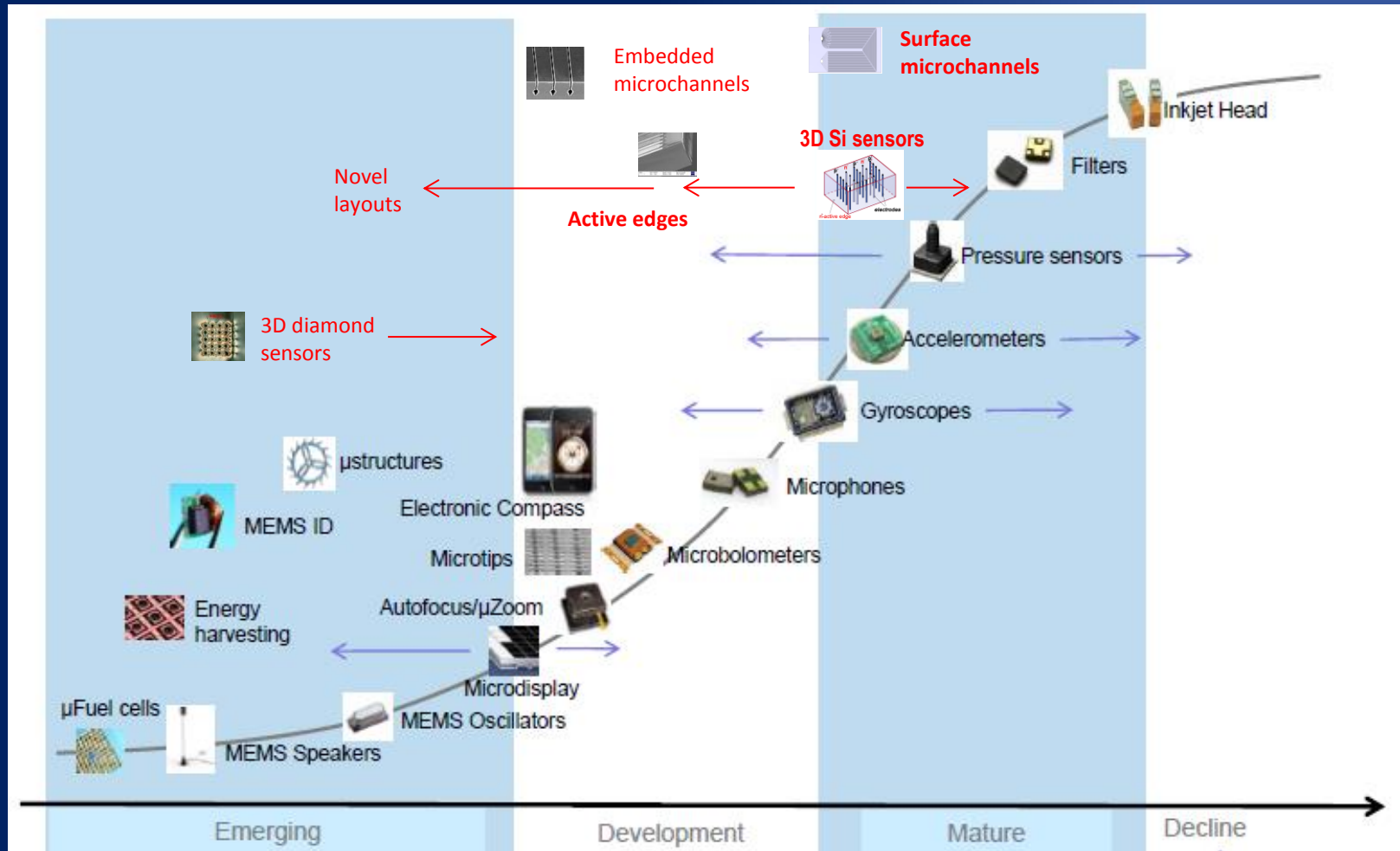
Every Day MEMS & Market driven development

TODAY



- Others (microstructures, micro tips, flow meter ...)
- Oscillators
- RF MEMS
- Microfluidics
- Optical MEMS
- Micro displays
- Uncooled IR
- Combos
- Compasses
- Gyroscopes
- Accelerometers
- Microphones
- Pressure Sensors
- InkJet Heads

MEMS Evolution

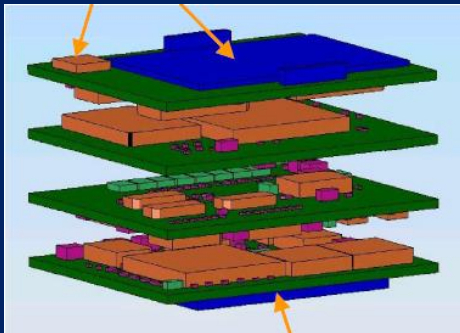


IBL 3D sensors are here

3D vertical integration, Micro-Systems and "More than Moore"

- **3D-"System-in-a-Package" (3D-SiP):** Integration on the package level. Where multiple dies are integrated in the same package. The resultant packages are afterwards stacked on top of each other using flip chip technology.
- **3D-"Wafer level packaging" (3D-WLP):** Integration at wafer level. Interconnection is usually made by through wafer "vias" with a relatively large diameter of e.g. 150 μm
- **3D-"Stacked IC" (3D-SIC):** Integration on IC foundry level (see V. Re talk)

L1-Opto-electronic

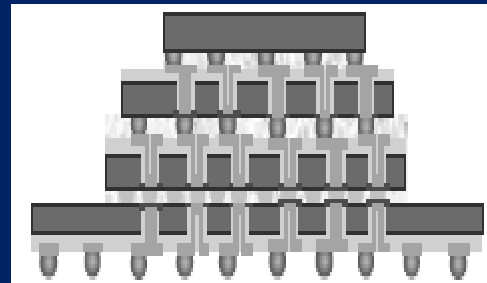


3D-SiP

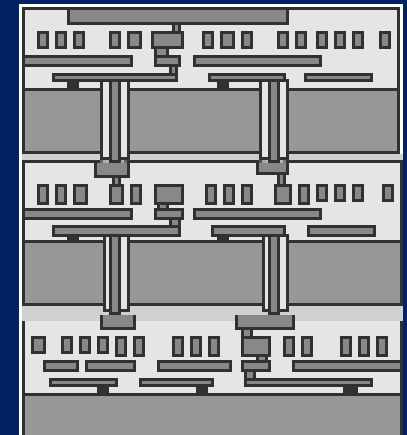
L2-FPGA

L3-Bus

L4-IC



3D-WLP



3D-SIC

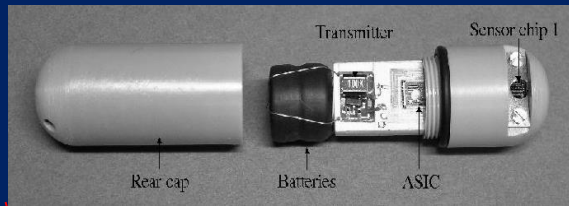
Applications in Bio-Medicine

Source: S. Bhansali

MEMS sensors in the biomedical field maybe used as:

- ❖ Critical sensors, used during operations.
- ❖ Long term sensors for prosthetic devices.
- ❖ Sensor arrays for rapid monitoring,
- ❖ Diagnosis at home.

<http://www.spie.org/web/oer/august/ug00/cover2.html>
<http://www.see.ed.ac.uk/~tbt/norchip2002.pdf>



35mm

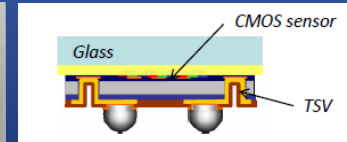


"lab on a pill"

- ❖ Digital camera (CMOS Technology)
- ❖ Light source
- ❖ Battery
- ❖ Radio transmitter
- ❖ Sensors (MEMS Technology)

- The pill is intended to be swallowed like any normal pill.
- Once within the body, the pill's sensors sample body fluids and pick up "meaningful patient data" such as temperature, dissolved oxygen levels and pH.
- The pill is expected to retrieve all data over a 12-hour period and disposed off,
- This data is transmitted wirelessly to a card attached to the wrist of the individual.

"Ultra miniaturized camera for endoscopy with TSVs"



Source: I-Micronews
May 2011

"Precision scalpels"

MEMS piezoelectric motor help to accurately position the scalpel.
MEMS pressure sensors incorporated on the scalpel, can help to measure the force exerted on the area operated upon. Accordingly, the scalpel can be handled.

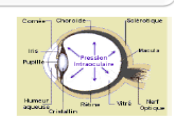





http://www.ee.ucla.edu/~jjud/publications/conference/msc_2000_jud.pdf

Applications in Bio-Medicine

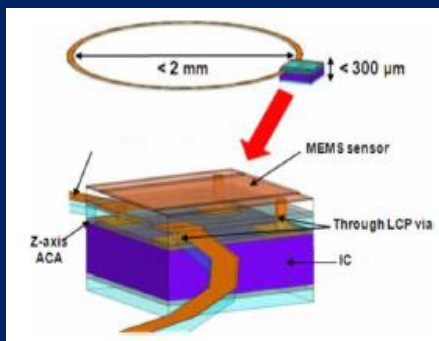
Source: Lami EposS 2012

Pressure Sensing

<p>Ocular pressure</p>  <p>9mmHg <P< 21 mmHg</p>	<p>Blood pressure</p>  <p>P_{ystolique} < 15 cmHg. P_{diastolique} < 9cmHg</p>	<p>Intra-brain pressure</p>  <p>2mmHg <P< 20 mmHg</p>	<p>Bladder pressure</p>  <p>0mmHg <P< 15 mmHg</p>
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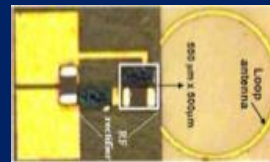
Glaucoma diagnosis



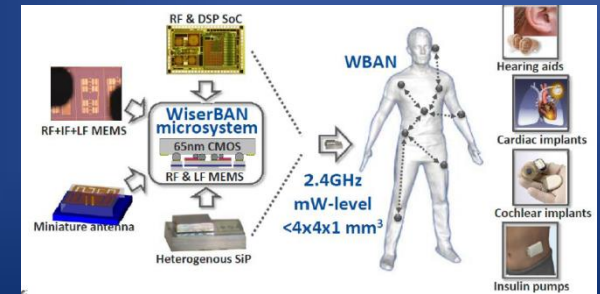
3D IC and MEMS stacking

Inserted in a mouse's eye

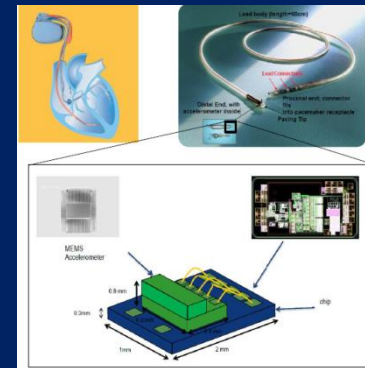
D. Ha et al. IMS 2010



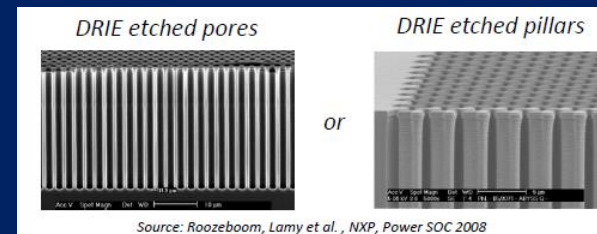
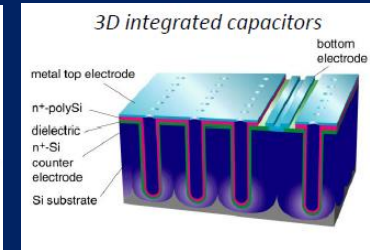
Implantable Devices



Acceleration monitoring in pacemakers



Energy Management
500 nF/mm
Using high k dielectrics



Source A. Rippart INEMI 2011

Silicon Micro-dosimetry

Mimic Project
 A. Kok et al SINTEF
 C. Da Via STFC-CLASP proposal

Microdosimetry measures the stochastic energy deposition events at cellular level

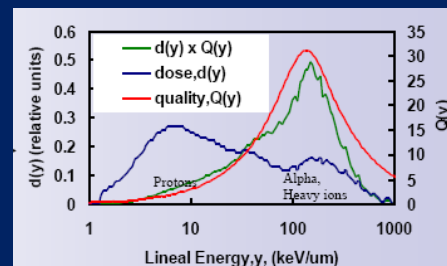
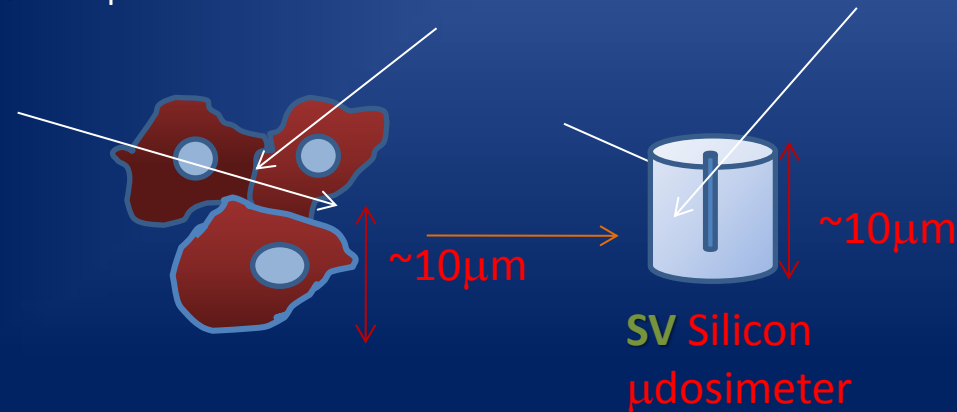
❖ Radio-Biological Effectiveness (RBE) depends on linear energy transfer (LET or Lineal Energy) which is different for different radiation type. **Average chord length $\langle l \rangle$** independent on radiation direction

❖ **Mixed Field** detection in a small sized array of cell-like elements of well defined Sensitive volume **SV** is required to precisely determine RBE

❖ Silicon Dose Equivalent can be determined From the lineal Energy Spectra and the tissue equivalent dose D_{TE} . Quality factors Q determined Experimentally.

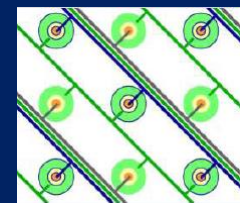
$$D_{Si} = D_{TE} S_{Si}/S_{TE}$$

$$\text{Dose equivalent } H = Q D_{Si}$$

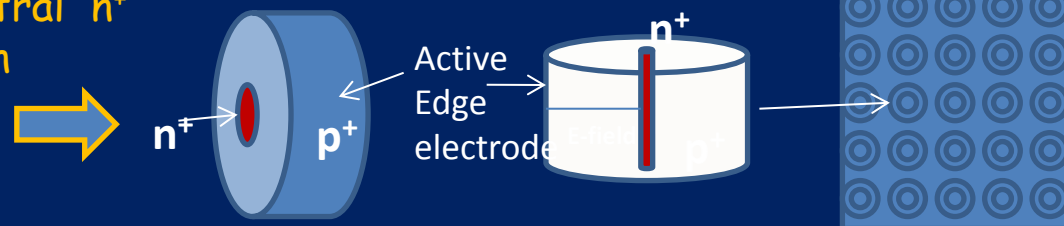


Plot from Rosenfeld et al

Dose distribution $d(y)$

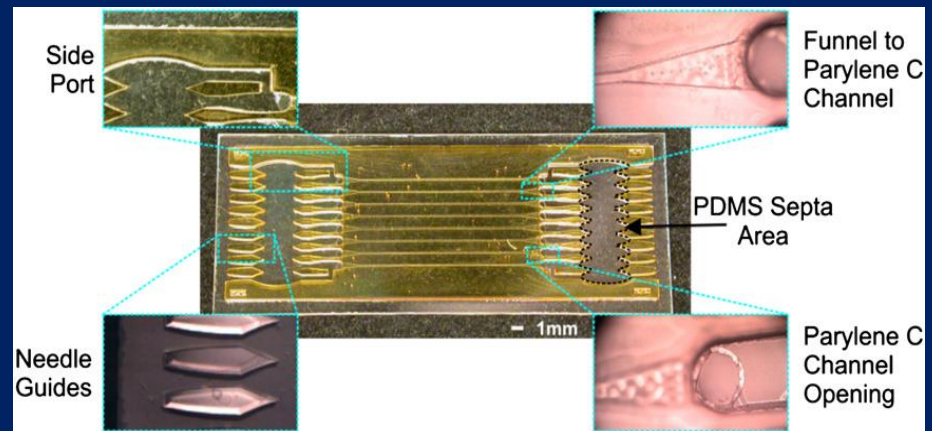
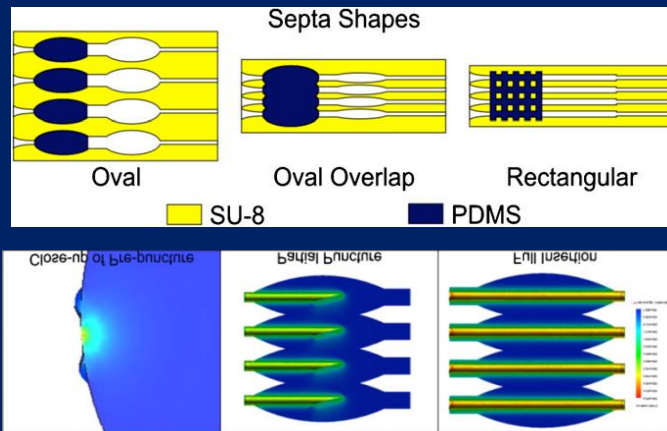
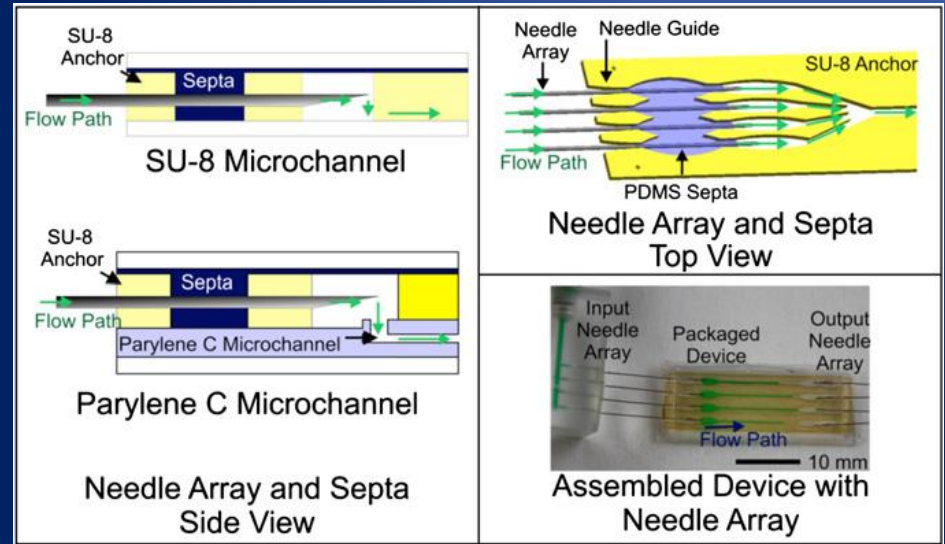


Use array of 3D sensors with central n^+ electrode surrounded by p^+ trench to define cellular size sensitive volume



Micro total-analysis systems (μ TAS) and lab-on-a-chip (LOC)

- ❖ microfluidics are used in applications such as chemical synthesis, genetic analysis, drug screening and single cell/molecule analysis
- ❖ in-plane interconnect using a 'pin-and-socket' approach in which a single commercially available non-coring needle (33G) accessed a microfluidic device by puncturing a polydimethylsiloxane (PDMS) septum



R Lo1 and E Meng

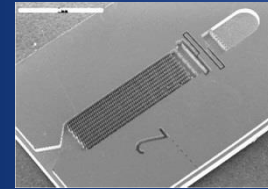
Department of Biomedical Engineering, University of Southern California, 149 Commonwealth Drive, Menlo Park, CA 94025, USA

Applications in Space

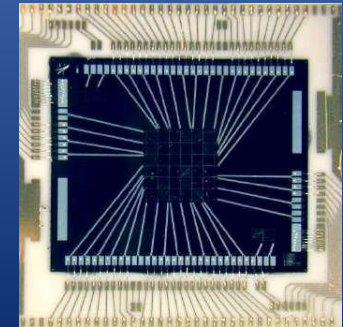
MEMS and Microstructures in Aerospace Applications
 Published in 2006 by RC Press Taylor & Francis Group
 6000 Broken Sound Parkway NW, Suite 300 Boca Raton, FL 33487-2742

The MEMS technologies included in the NASA inventory:

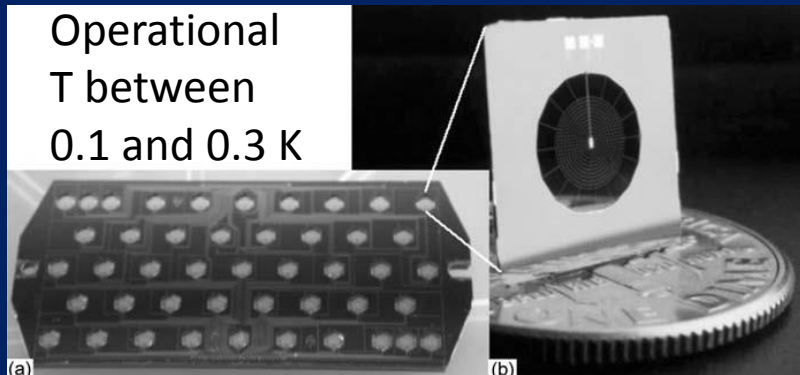
- . Stirling coolers
- . liquid-metal micro-switches
- . inertial sensors
- . microwave RF switches and phase shifters
- . thrusters
- . deformable mirrors
- . pressure or temperature sensors
- . power supplies
- . sensors



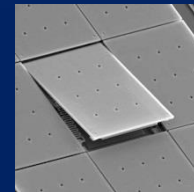
Propulsion thrusters



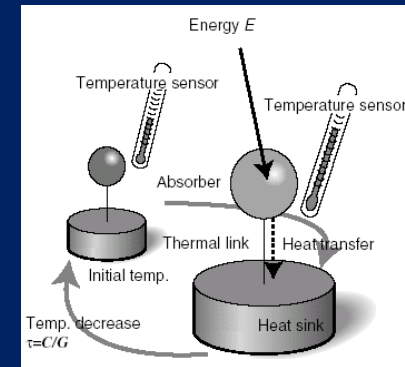
X-Ray sensor being used For the SUZAKO x-ray spectrometer



Operational
 T between
 0.1 and 0.3 K



μ -mirrors



Used as a very sensitive T Sensor T prop to E (x-ray)

microfabricated “Spider Web” bolometers, JPL
 high-purity, neutron transmutation doped (NTD), single crystal Ge thermistor chip mounted on a “spider web” suspension comprising metallized, suspended SiN filaments

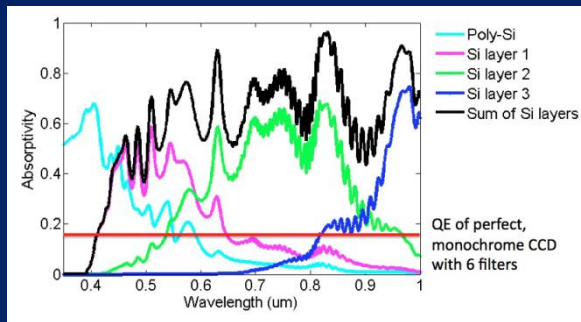
Multi-Layer Polychromatic CCD

Astronomy, Cosmology

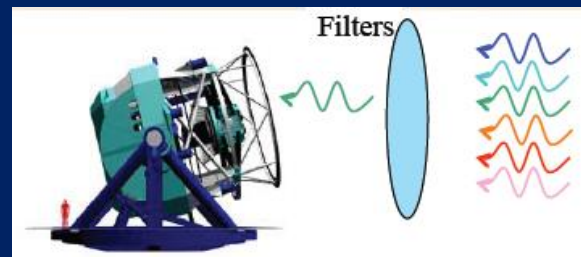
Chu-En Chang, J. Segal, R. Howe, A. Roodman, SLAC
Material from C. Kenney

Imager, which can record the intensity of light within multiple color bands and with high quantum efficiency

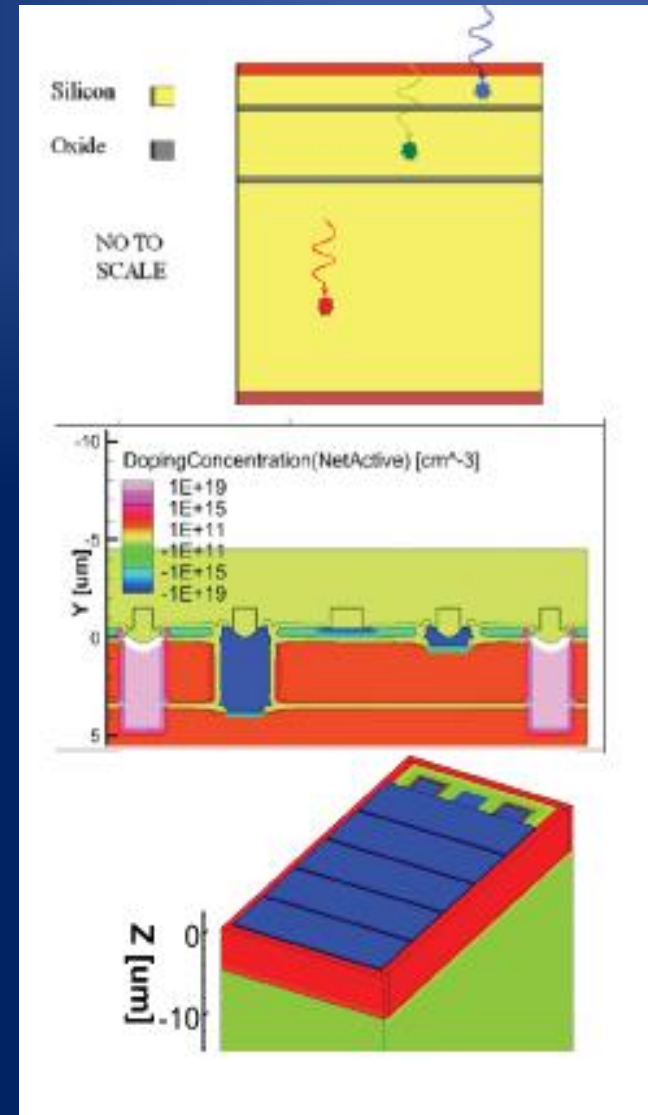
- Basic idea is to make a multi-layer CCD to replace a monochromatic CCD with a 'color-sensitive' device
- All layers are clocked out simultaneously by the same set of gate electrodes
- Each layer readout separately, but simultaneously
- Employ micro-machining technology for channel stops and read-out contacts - similar procedure used for 3D sensors



Simulation of quantum efficiency for Poly-chromatic versus mono-chromatic CCDs



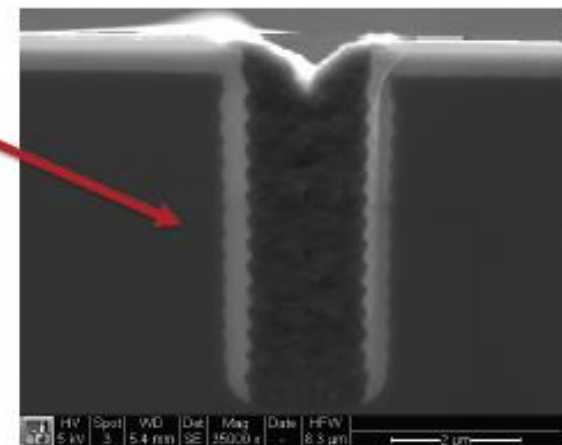
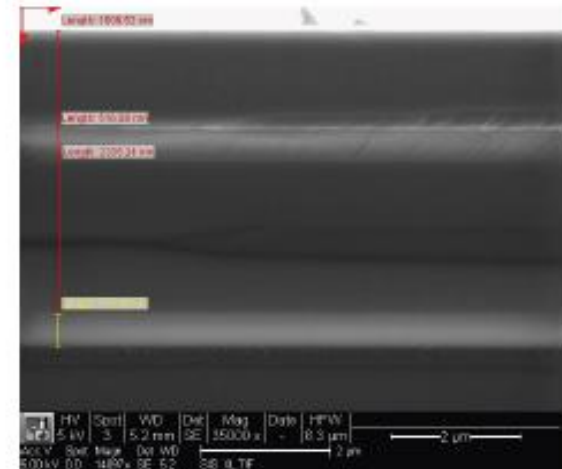
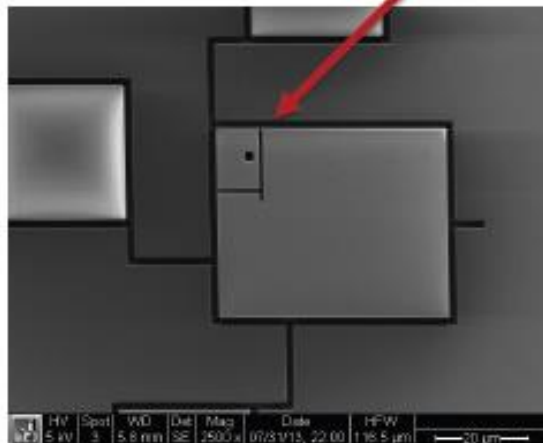
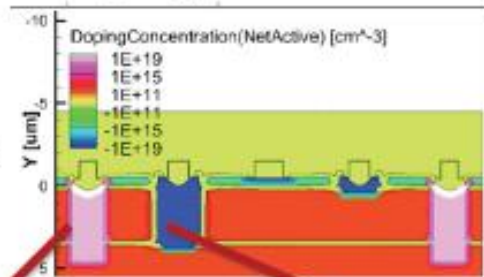
Application in wide-area Optical surveys for cosmology



Multi-layer CCDs prototype

Fabrication of many layers of thin, float-zone silicon separated by oxide films done in partnership with local company

Channel-stop trenches same as used in 3D sensors



Isolated, conducting vias demonstrated

Wire-bonding free electrical connectors

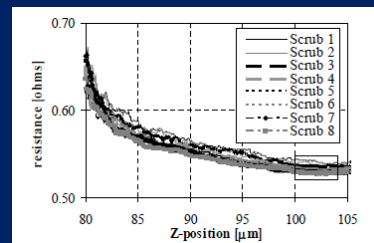
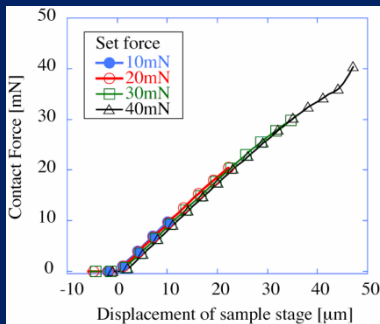
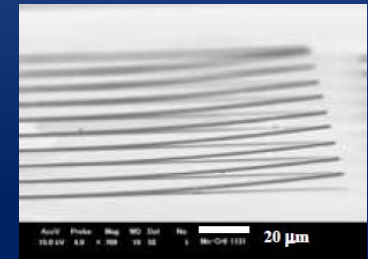
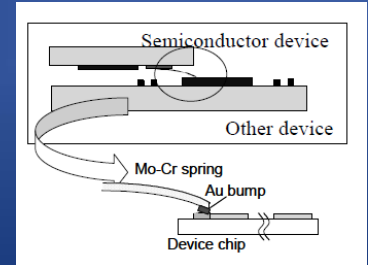
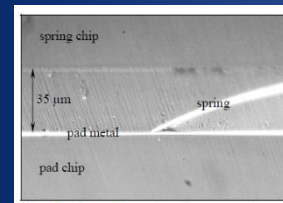
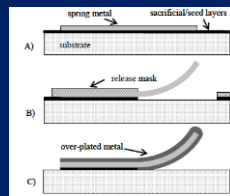
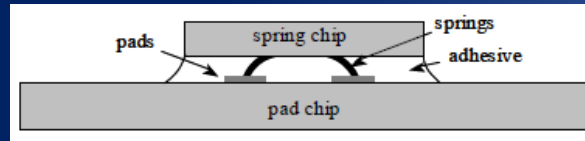
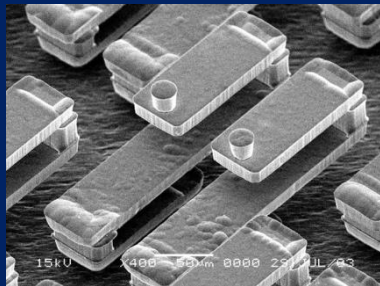
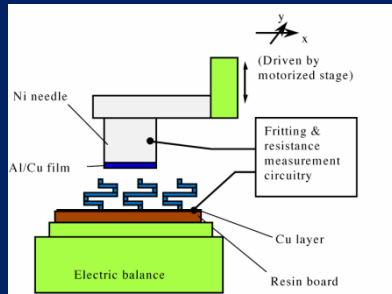


Table I Contact resistance and sheet resistance of metals deposited using various process.

Material	Contact resistance (Ω)	Sheet resistance (mΩ/□)	Particle size (nm)
Mo-Cr	0.0628	192.5	-
Au (EB deposition)	0.044	12.8	unable to measure
Au (pulse plating (i))	0.0314	18.15	50-500
Au (pulse plating (ii))	0.0078	9.72	50-500
Au (ultrasonic plating)	0.0035	6.7	250

Kenichi Kataoka
 Research Center for Advanced
 Science and Technology,
 The University of Tokyo

Solder-Free Pressure Contact Micro-Springs in High-Density Flip-Chip Packages

Eugene M. Chow, Chris Chua, Thomas Hantschel, Koenraad Van Schuylenbergh, David K. Fork
 Palo Alto Research Center (PARC)

Chip-Bonding for Integrated Circuit by using Micro-spring Probe

Chinami Kaneshiro, Kohji Hohkawa
 Kanagawa Institute of Technology

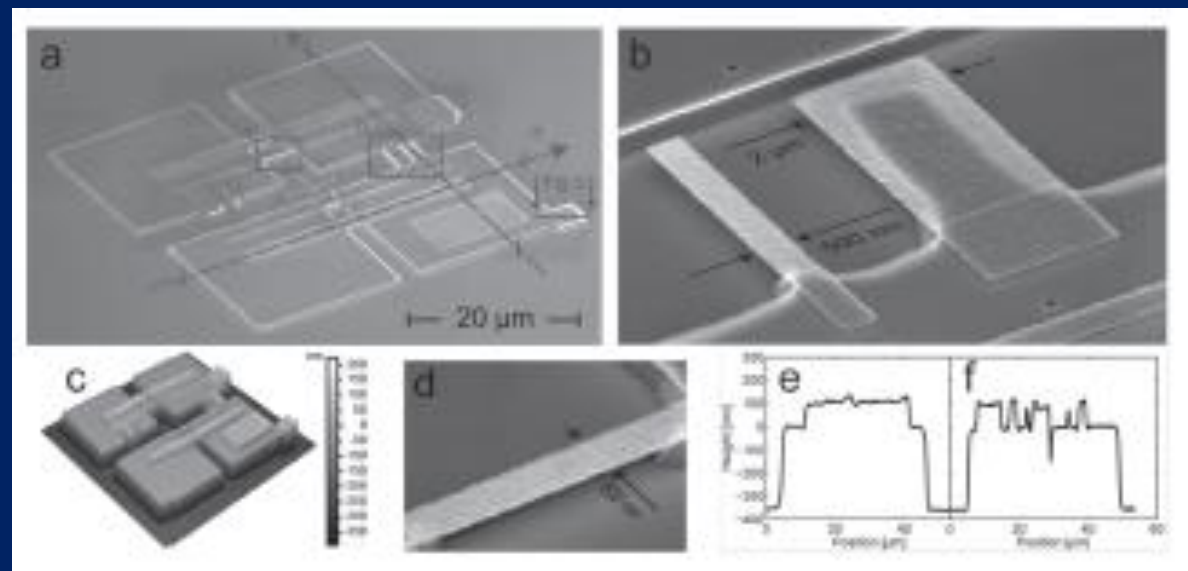
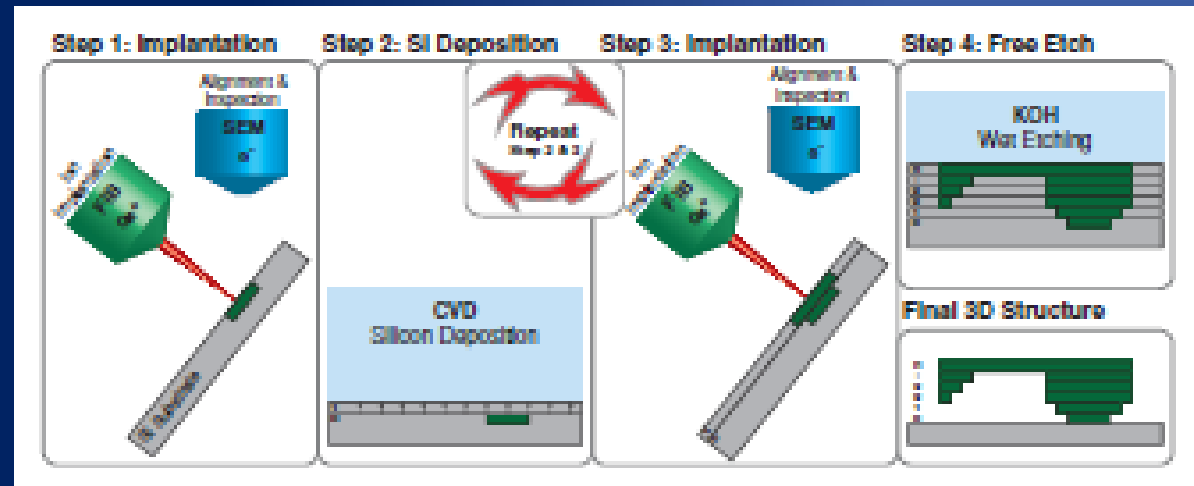
The future: 3D printing

Adv. Funct. Mater. 2012, 22, 4004–4008

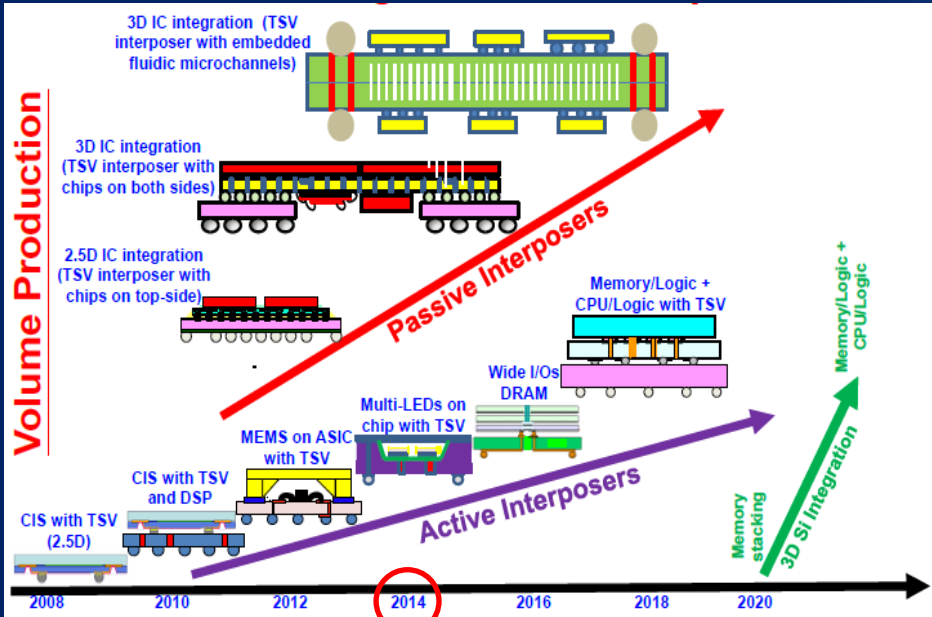
The layer-by-layer fabrication is based on alternating steps of chemical vapor deposition of silicon and local implantation of gallium ions by focused ion beam (FIB) writing.

In a final step, the defined 3D structures are formed by etching the silicon in potassium hydroxide (KOH), in which the local ion implantation provides the etching selectivity.

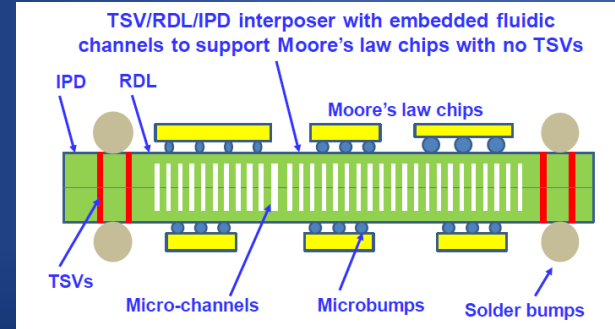
The method is demonstrated by fabricating 3D structures made of two and three silicon layers, including suspended beams that are 40 nm thick, 500 nm wide, and 4 μ m long, and patterned lines that are 33 nm wide.



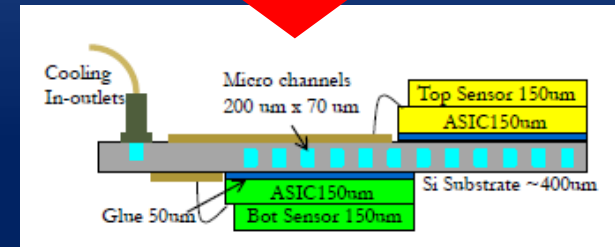
More than Moore: 3D integration roadmap



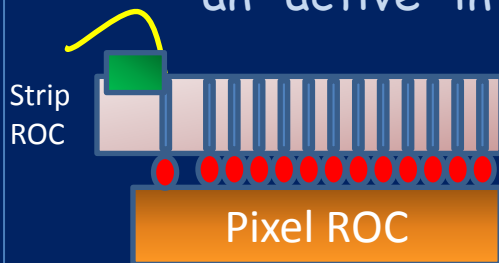
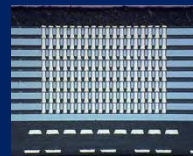
Source: John Lau, ITRI, InterPACK 2011



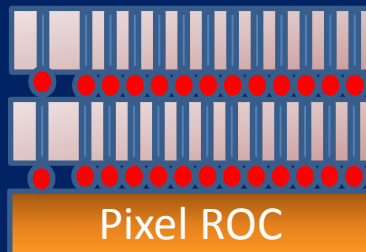
LHCb layout



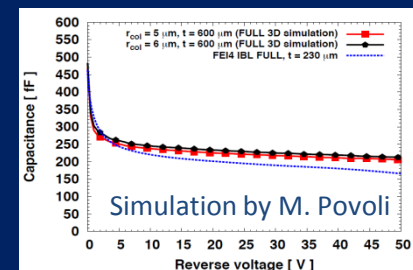
3D sensor can be used as an "active" interposer



Dual readout



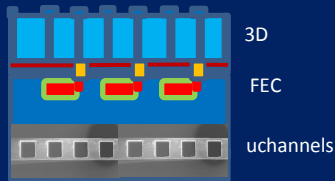
"Stacked" 3D sensors



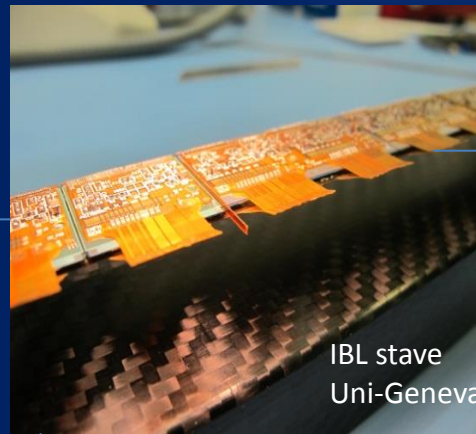
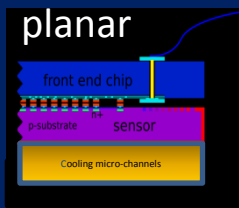
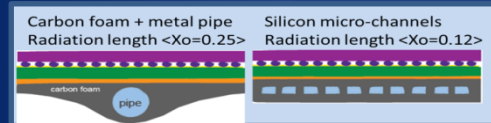
Applications on momentum Discrimination and "charge-share" free x-ray imaging

A Future Innermost layer in ATLAS?

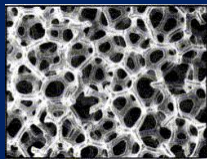
Rad-Hard sensors +
Micro-channel cooling +
Electro-mechanical connectors on superlight supports



Micro-connector



IBL stave
Uni-Geneva

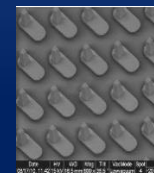
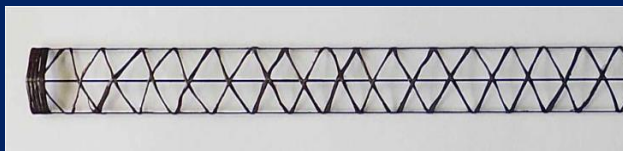


SiC foam

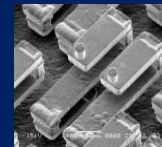


PLUME

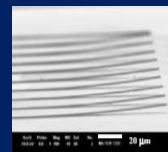
Carbon fiber



MEMS techniques to produce lithographically printed probe cards capable of $6 \mu\text{m}$ sq. x $20 \mu\text{m}$ high probe tips on $40 \mu\text{m}$ pitch are also possible
@Cascade Microtech



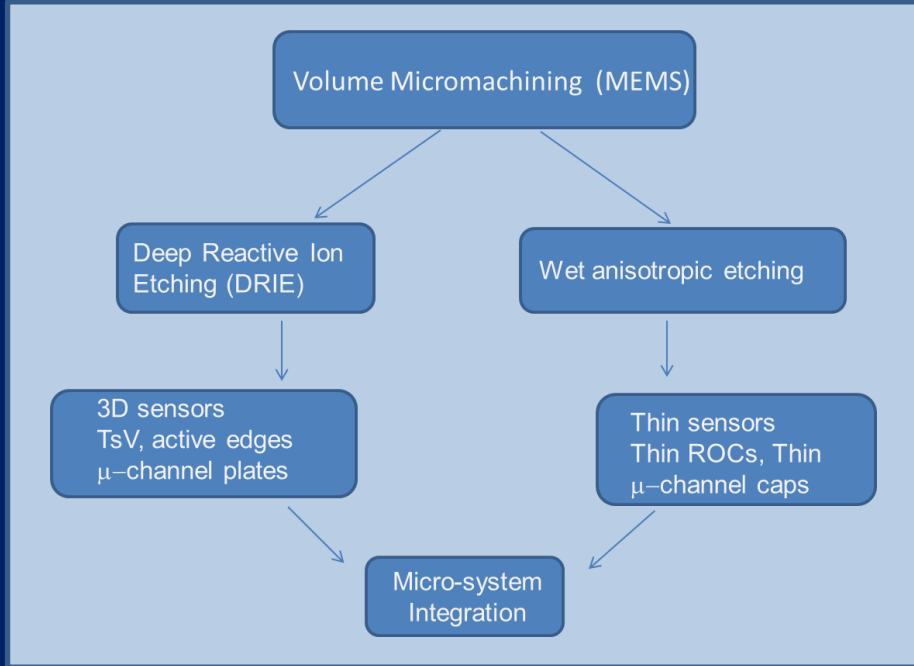
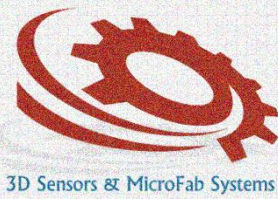
M-probe by Kenichi Kataoka Research Center for Advanced Science and Technology, The University of Tokyo



Micro-wire spring made of elastic metal materials, coated with Au film
At Kanagawa Institute of Technology

Micro-Fabrication is a proposed CERN RD

24 Institutions from all LHC experiments + 7 processing facilities



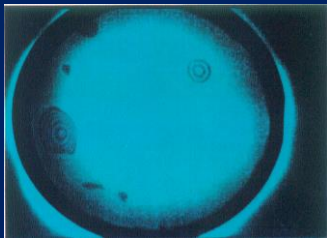
This project gathers 7 major facilities with proven skills to perform all the required processing and integration steps of the proposed program

Together we believe we can solve "faster" and "cheaper" technological and production challenges

Potential technology transfer to other fields

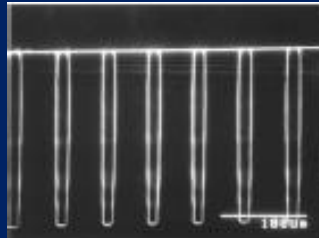


Wafer bonding
mechanical stability
Active edge 3D sensors
Thin electronics
micro-channels capping



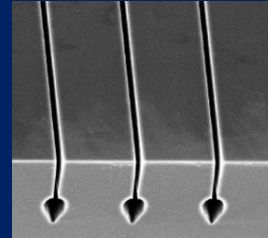
CIS-Stanford

3D electrodes and active edges single side
3D double side sensors



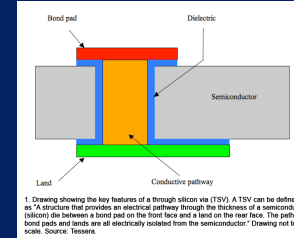
CNM

Embedded micro-channels



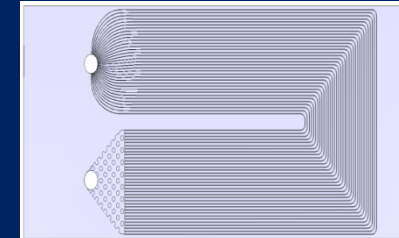
FBK-Pisa

Integration, TsV



IZM-CSEM-LETI

Superficial micro-channels



EPFL-CERN-LHCb

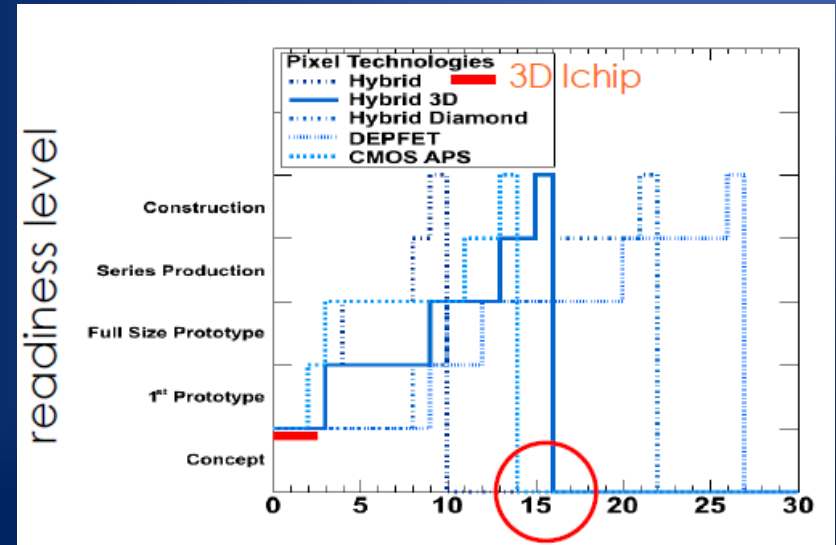
Conclusions and Outlook

❖ Micro-Fabrication is offering good opportunities for future Vertex systems at The LHC beyond 3D sensors, Micro-cooling and TsV.

❖ A lot of the development is Market driven but also research driven in biology, and space applications and we should take advantage of it!

❖ In particular if this involves a new concept since the average time to get to maturity for a new technology is ~15 years.

It seems we will have time..



From A. Cattai

